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AM Data Management Working Group Additive Manufacturing Common Data Model

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Overarching Goal



- Make Additive Manufacturing (AM) data FAIR indable, Accessible, Interoperable, and Reusable
- Lack of a common vocabulary, common representation, and common exchange formats all hinder these goals
- According to GO FAIR the FAIR Principles include:
 - Findable: "Metadata and data should be easy to find for both humans and computers."
 - Interoperable: "(Meta)data use a formal, accessible, shared and broadly applicable language for knowledge representation." and
 - Reusable: "... metadata and data should be wellscribed so that they can be replicated and/or combined in different settings."

Common Data Model in context of CDD and CDEF

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Common Data Dictionary

- build ID globally unique identifier of a build, of type string
- powder lot ID globally unique identifier of a lot of powder, of type string
- powder reuse number the number of times the powder has been reused, of type in № 0
- ASTM F349@1

Defines terms, but no structure/relationships —good for humans, not machines

Common Data Model

```
Build is a class,
  defined by buildID with a single
  value of type string,
  defined by powderLot with values
  of type PowderLot. // by saying "with
  values" I am stating that a single build
  could use multiple powder lots
```

>>

PowderLot is a class,
 defined by powderLotID with a
 single value of type string,
 defined by powderReuseNumber with
 a single value of type int.

Defines logical structure and relationships in a human - and computer -readable format

Common Data Exchange Format

Defines format for systems to share data, aligned to the CDM in both structure and terms

The CDEF is built to exchange data modeled by the CDM, which puts structure around the CDD. So, the CDEF builds upon the CDM, which in turn builds upon the CDD.

Making Additive Manufacturing Data FAIR through a Common Data Model



Users can explore & select attributes of interest from a Common Data Model (CDM)





SemTKuses metadata mappings linking CDM to each data stores' data model to generate querie

Data retrieved from stores and mapped to CDM for integration

Retrieve & Map GEFDIP → CDM



GE Federated Digital Thread Platform

Retrieve & Map AMMD → CDM



NIST AMMD

Retrieve & Map AFRL HT → CDM



AFRL HyperThought

Retrieve & Map
DMSAM → CDM



Hexagon MaterialCenter

Retrieve & Map Sys X → CDM



System X

Use a Common Data Model to make additive manufacturing data Findable Accessible Interoperable and Reusable

AM Common Data Model Working Group



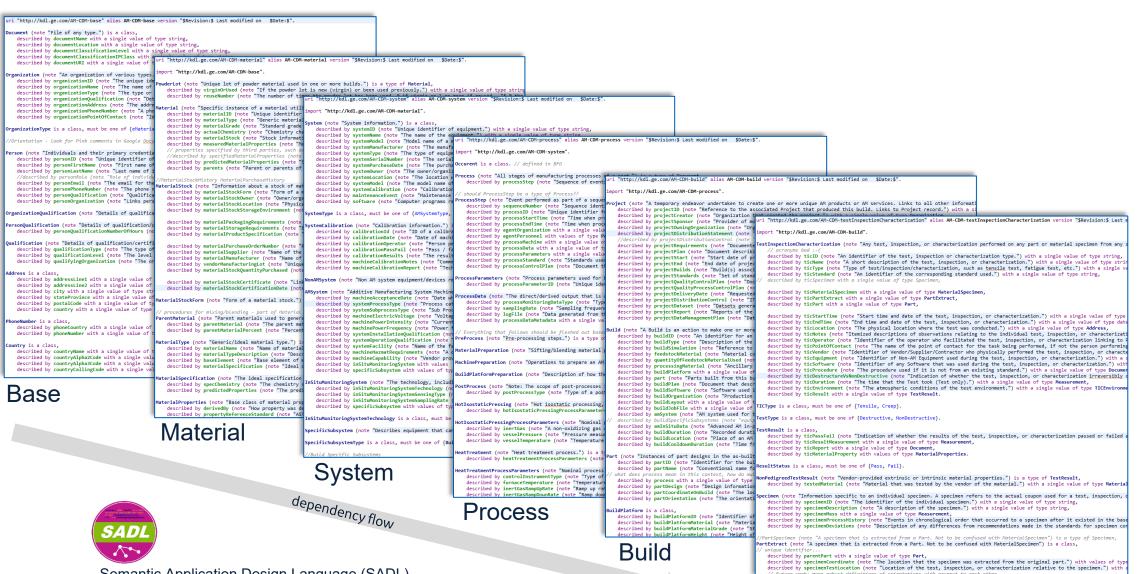
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GitHub repo: https://github.com/kaggour/AM-CDM

Excerpts from CDM (written in SADL)



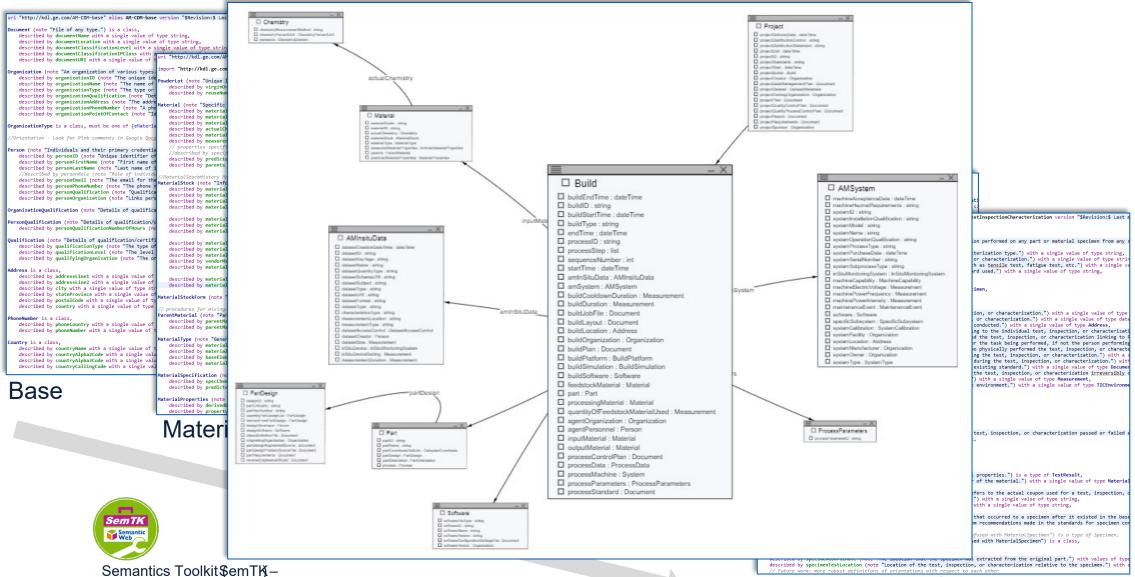


Semantic Application Design Language (SAPL) https://github.com/SemanticApplicationDesignLanguage

Build-centric view (visualized in SemTK)

https://github.com/ge-semtk/semtk





Material-centric view (visualized in SemTK)



